## Universida<sub>de</sub>Vigo

## Subject Guide 2014 / 2015

IDENTIFYIN	G DATA			
(*)Deseño e	Fabricación de Circuítos Integrados			
Subject	(*)Deseño e			
	Fabricación de			
Codo				
Study	(*)Mástor			
programme				
programme	Enxeñaría de			
	Telecomunicación			
Descriptors	ECTS Credits	Choose	Year	Ouadmester
	5	Mandatory	1st	2nd
Teaching	Spanish	· · · · ·		
language				
Department				
Coordinator	Fariña Rodríguez, José			
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	Fariña Rodríguez, José			
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Web				
	<ul> <li>a) To know how to analyze and dimensioning the technology.</li> <li>b) To know and be capable to use software tools</li> <li>c) To know to specify an integrated circuit for mage.</li> </ul>	for the design of integ nufacturing in CMOS t	ppologies of analog rated circuits. echnology.	g circuits in CMOS
Competenc	ies			
Code				
A4 CB4 Stu non-spe	dents must communicate their conclusions, and t cialists in a clear and unambiguous way.	he knowledge and rea	sons stating them	, to specialists and
A5 CB5 Stu way	dents must have learning skills to allow themselv	es to continue studyin	g in largely self-dir	rected or autonomous
A13 CG8 Th and mu	e ability to apply acquired knowledge and to solve tidiscipline contexts, being able to integrate know	e problems in new or un vledge.	nfamiliar environm	ents within broader
A28 CE10 T	ne ability to design and manufacture integrated ci	rcuits.		
Learning ai	ms			
Expected res	ults from this subject		Typology	Training and Learning Results
CB4 Student stating them	s must communicate their conclusions, and the kr -, to specialists and non-specialists in a clear and	nowledge and reasons unambiguous way.	know	A4
CB5 Student largely self-c	s must have learning skills to allow themselves to irected or autonomous way	continue studying in	Know How	A5
CG8 The abi environment knowledge.	ity to apply acquired knowledge and to solve prob s within broader and multidiscipline contexts, beir	plems in new or unfaming able to integrate	liar Know How	A13
CE10 The ab	ility to design and manufacture integrated circuits	5.	Know How	A28
Contents				
Topic				
Chapter 1: Ir	troduction (1h) Course intro microelectro	duction. Objectives an nic design of integrate	d course planning. ed circuits (ICs).	Basic concepts of

Chapter 2: Manufacturing sequence for ICs (1h)	Introduction to ICs manufacturing. Planar technology. Manufacturing sequence of ICs in CMOS technology. Structure of MOS transistors. Manufacturing example: CMOS inverter. Masks pattern (layout). Technological design rules. Methodologies and tools for design assistance.
Chapter 3: Physical structure of basic devices and routing strategies (1h)	ISpecification of the physical structure of MOS transistor. Specification of the physical structure of a resistor. Specification of the physical structure of a capacitor. Strategies for performing transistors with high aspect ratio. Strategies for matched transistors.
Chapter 4: Basic amplifier topologies (2h)	Common source topology. Common drain topology. Common gate topology. Cascode topology. Push_Pull amplifier. Physical design examples.
Chapter 5: Current mirror (3h)	Current sources. Basic structure of a current mirror. Analysis of functioning. Frequency response. Cascode topology. Physical design examples.
Chapter 6: Differential pair (3h)	Differential pair structure. DC analysis. AC analysis. Specifications and design of the physical structure of a self-biased differential amplifier topology. Common mode rejection ratio. Matching of transistors. Slew rate limitations. Physical design examples.
Chapter 7: Operational amplifier (2h)	Two stages operational amplifier. Design parameters. Operational Transconductance Amplifier (OTA). Examples of physical designs.
Chapter 8: Preparing for manufacturing (2h)	Distribution in the base plane. Pad and terminals. Specification formats. Packages.
Laboratory session 1: Introduction to design tools for ICs (2h)	Introduction to design tools for analog ICs. Current mirror example. Electric simulation. Design Rules Check (DRC) and layout extraction.
Laboratory session 2: Design of self-biased differential pair (2h)	Electrical specification. Characterization of DC operating parameters. Characterization of AC operating parameters.
Laboratory session 3: Design of self-biased differential pair II (2h)	DRC and layout extraction. Layout versus schematic (LVS). Post-layout simulation.
Laboratory session 4: Design of a transconductance amplifier (2h)	Electrical Specification. Physical specification. Operation testing.
Laboratory session 5: Preparing for manufacturing (2h)	For the circuit obtained in Laboratory session 4, perform the required steps to create the information needed in order to send the circuit to manufacture.

Planning			
	Class hours	Hours outside the classroom	Total hours
Master Session	14	28	42
Troubleshooting and / or exercises	4	28	32
Laboratory practises	9	22.5	31.5
Short answer tests	1	4	5
Troubleshooting and / or exercises	1	5.5	6.5
Practical tests, real task execution and / or simulated.	1	7	8

\*The information in the planning table is for guidance only and does not take into account the heterogeneity of the students.

Methodologies	
	Description
Master Session	The professor will present the relevant concepts of the course. Before each lecture, students must carry out a preparation analysis of the topics to be addressed. The aim is to encourage active participation of students, who may ask questions or expose doubts during the session. For a better understanding of certain content, practical examples or case studies will be discussed
Troubleshooting and / o exercises	r Students will work in small teams (C-type groups) in the physical design and characterization of a circuit consisting of active devices and passive components, under the close guidance of professors. Attendance will be recorded. The activities to be developed by each team are: - Analysis of possible solutions and design alternatives.
Laboratory practises	Students work in groups of two people. They will work with IC CAD tools for IC design, in which they will carried out the definition of an electronic circuit both electrical and physical level, the verification of compliance with specifications and design preparation for manufacturing. Attendance will be recorded and performance of each group in each lab assignment will be evaluated.

Personalized atten	tion
Methodologies	Description

Master Session	The teaching staff will attend doubts and enquiries of the students about the theoretical contents, previous preparation of laboratory practices as well as its contents. Professors will also resolve the doubts and enquiries of students about specifications, theoretical and practical aspects of the assigned project as well as those about the content and structure of the explanatory report. In addition, students will be guided about the structure and contents of the sessions of presentation and defense of the results achieved in the project. Students will have the opportunity to attend personalized or group mentoring.
Laboratory practises	The teaching staff will attend doubts and enquiries of the students about the theoretical contents, previous preparation of laboratory practices as well as its contents. Professors will also resolve the doubts and enquiries of students about specifications, theoretical and practical aspects of the assigned project as well as those about the content and structure of the explanatory report. In addition, students will be guided about the structure and contents of the sessions of presentation and defense of the results achieved in the project. Students will have the opportunity to attend personalized or group mentoring.
Troubleshooting and / or exercises	The teaching staff will attend doubts and enquiries of the students about the theoretical contents, previous preparation of laboratory practices as well as its contents. Professors will also resolve the doubts and enquiries of students about specifications, theoretical and practical aspects of the assigned project as well as those about the content and structure of the explanatory report. In addition, students will be guided about the structure and contents of the sessions of presentation and defense of the results achieved in the project. Students will have the opportunity to attend personalized or group mentoring.

Assessment		
	Description	Qualification
Troubleshooting and / or exercises		0
Laboratory practises		0
Short answer tests	As part of the continuous evaluation, it will take place in mid-course an individual written test of 30 minutes, in one of the lecture sessions. This test will involve 10% of the final grade. This test is the last chance for students to decide whether or not they opt for continuous evaluation. All students completing the test implicitly choose to follow continuous evaluation. The remaining students have to explicitly declare their choice. The lack of declaration from a student means he/she will not follow continuous evaluation. Another written test of 60 minutes will be held in the date of the final exam. This test will have two parts and it is compulsory in whole for students not in continuous evaluation. Students in continuous evaluation can also voluntarily complete the first part since the contents correspond to the first written test. In that case, the score they will receive in this part of the course evaluation will be the one achieved in this second test. The second part of the test is mandatory for all students. Each of the parts will involve 10 % of the final qualification. To pass the course, students must achieve in each part a mark of 4 or higher in a 0-10 scale (or in the intermediate test, where appropriate). Competences CE10 and CB4 will be assessed in these tests.	20 F
Troubleshooting and / or exercises	As part of the continuous evaluation, it will take place in mid-course an individual written test of 30 minutes, in one of the lecture sessions. This test will involve 10% of the final grade. This test is the last chance for students to decide whether or not they opt for continuous evaluation. All students completing the test implicitly choose to follow continuous evaluation. The remaining students have to explicitly declare their choice. The lack of declaration from a student means he/she will not follow continuous evaluation. Another written test of 60 minutes will be held in the date of the final exam. This test will have two parts and it is compulsory in whole for students not in continuous evaluation. Students in continuous evaluation can also voluntarily complete the first part since the contents correspond to the first written test. In that case, the score they will receive in this part of the course evaluation will be the one achieved in this second test. The second part of the test is mandatory for all students. Each of the parts will involve 10 % of the final qualification. To pass the course, students must achieve in each part a mark of 4 or higher in a 0-10 scale (or in the intermediate test, where appropriate). Competences CE10 and CB4 will be assessed in these tests.	20
Practical tests, real task execution and / or simulated.	· · ·	0

## Other comments on the Evaluation

Final test will be 50% of the overall grade of the course. It will consist of two parts: short answer questions and resolution of problems. The part of the questions will represent 40 % of the test qualification and the part of resolution of problems the other 60%. In order to calculate the grade it is necessary to obtain at least 50 % of the maximum score for each part.
They must develop a project, and deliver the corresponding report and public presentation (in the same sessions and with the same criteria as students in continuous evaluation). Reports are due two days before the public presentation. The project qualification will involve 50% of the overall grade of the course. In the final qualification of the project, the memory report has a corresponding percentage of 70% and the other 30% is obtained from the qualification of the presentation. In order to calculate the grade it is necessary to obtain at least 50 % of the maximum score for each part.

Students not passing the course in the first call will have the opportunity to attend a second call. To pass the course, students must achieve in each part at least 50 % of the maximum score.

## Sources of information

Behzad Razavi, Design of Analog CMOS Integrated Circuits, McGraw Hill,

Paul R. Gray, Paul J. Hurst, Stephen H. Lewis, Robert G. Meyer, **Analysis and Design of Analog Integrated Circuits**, John Wiley & Sons,

R. Jacob Baker, CMOS Circuits desing, Layout and Simulation, John Wiley & Sons,

J. Franca, Y. Tsividis, **Design of analog VLSI circuits for telecommunications and signal processing**, Prentice Hall,

Recommendations